

Search Notes

Application/Control No.

10/750,018

Examiner

Binh V. Ho

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2163

SEARCHED

Class	Subclass	Date	Examiner
707	103R	6/9/2006	BH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
707/104.1,103R,1-6,200,2005	6/9/2006	BH